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Measurement of the Charged Kaon Mass Using the MIPP RICH

NICK GRAF, Indiana University, MIPP COLLABORATION — The current charged kaon mass of $493.677 \text{ MeV} \pm 26$ parts per million (ppm) is dominated by two measurements of kaonic atom x-ray energies. These measurements have precisions of 14 and 22 ppm, respectively, and differ by 122 ppm. Given its importance in measurements of V_{us} from K^+ decay, resolution of the ambiguity in charged kaon mass measurements is needed. This talk describes a method for making a measurement with 40 ppm statistical precision from the correlation between p , π , and K RICH radii and precisely known values of proton and pion masses. Analysis of data from the Main Injector Particle Production (MIPP) experiment taken during spring 2006 at Fermilab is presented.

Nick Graf
Indiana University

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